

e08124r1

Meeting Minutes - T13 Device Statistics Conf Call
2008-07-14
1:00pm PST

Meeting Notes

Attendees

Joseph Chen, Samsung – y
Jim Hatfield, Seagate - y
Steve Livaccari, IBM - y
Yoni Shternhell, SanDisk - y
David Landsman, SanDisk – y

The agenda for the tele-conf is as the order listed:

1. e08106r1 Overview - last review 6/25 needs edit
2. e08127r0 Time Over Temperature - not reviewed
3. e06181r6 Errors - last review 6/16
4. e06180r8 Usage Length - last review 6/16
5. e07168r6 Transport - last review 6/16
6. e06184r9 Solid State - last review 6/16
7. e06183r9 Temperature - last review 6/25 ready for vote
8. e06182r6 Freefall - last review 6/25 ready for vote

Meeting results:

1. Meeting commenced at 1:00pm PST
2. Review the Device Statistics Overview document (e08106r2-Device_Statistics_Overview)
 - a. Joseph to mark Current Temperature Statistics is volatile, does not need to be saved.
 - b. Jim to upload the revised document to complete the workgroup discussion.
3. Review the Time in Over-Temperature document (e08127r0-Device_Statistics__Time_in_Over-Temperature.doc)
 - a. Add Time in Under-Temperature statistics
 - b. Add Specified Maximum Operating Temperature statistics
 - c. Add Specified Minimum Operating Temperature statistics
 - d. Joseph to hold on the revised document and continue discuss in the next meeting.